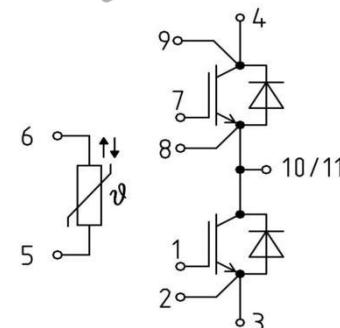


## EconoDUAL3 Trench-Field Stop IGBT Module

### DESCRIPTION

HGF200MJ120XXX designed for a 150° C junction operation temperature, the module accommodates a Half bridge configuration of Trench-Field Stop IGBT and matching emitter controlled diodes and NTC.

V <sub>CES</sub>	V <sub>CEsat</sub>		I <sub>CE</sub> /I <sub>CRM</sub>
1200V	T <sub>vj</sub> =25°C@200A	1.85V	200A/400A
	T <sub>vj</sub> =150°C@200A	2.2V	



### FEATURES

- Increased Blocking Voltage Capability To 1200V,  $T_{vjop} = 150^\circ C$
- High Short Circuit Capability, Self Limiting Short Circuit Current
- High Surge Current Capability and Density
- High Power Density, Increased DC Link Voltage
- Integrated NTC temperature sensor
- Standard Housing

### APPLICATIONS

- Commercial Agriculture Vehicles
- Motor Drives
- Solar Applications
- UPS Systems

### CHARACTERISTICS VALUES

#### MAXIMUM RATED VALUES(IGBT)

Parameter	Symbol	Conditions	Values	Units
Collector-emitter voltage	V <sub>CES</sub>	T <sub>vj</sub> =25°C, V <sub>GE</sub> =0V	1200	V
Continuous collector current	I <sub>CE</sub>	T <sub>c</sub> = 100° C, T <sub>vj max</sub> =175°C	200	A
Repetitive peak collector current	I <sub>CRM</sub>	t <sub>p</sub> = 1ms, T <sub>vj</sub> =25°C	400	A
Gate-emitter peak voltage	V <sub>GES</sub>	T <sub>vj</sub> =25°C	±30	V
SC data	I <sub>sc</sub>	V <sub>GE</sub> ≤15V, V <sub>CC</sub> =800V V <sub>CEmax</sub> =V <sub>CES</sub> -L <sub>Sce</sub> *di/dt, t <sub>p</sub> ≤10μs, T <sub>vj</sub> = 150°C	800	A
Total power dissipation	P <sub>tot</sub>	T <sub>c</sub> =25°C, T <sub>vj max</sub> = 175°C	955 <sup>1)</sup>	W

1) Verified by characterization / design not by test.

#### CHARACTERISTICS VALUES(IGBT)

Parameter	Symbol	Conditions	Values			Units	
			Min.	Typ.	Max.		
Collector-emitter saturation voltage	V <sub>CEsat</sub>	I <sub>c</sub> =200A, V <sub>GE</sub> = 15V	T <sub>vj</sub> =25°C	1.85	2.1	V	
			T <sub>vj</sub> = 125°C	2.1		V	
			T <sub>vj</sub> = 150°C	2.2		V	
			T <sub>vj</sub> =25°C	5	6	6.5	V

Gate-emitter threshold voltage	$V_{GEth}$	$I_c=6.4\text{mA}, V_{CE}=V_{GE}$	$T_{vj}=150^\circ\text{C}$	4.6		V	
Gate charge	$Q_G$	$V_{GE}=-8\text{V}/+15\text{V}$		2.3		$\mu\text{C}$	
Integrated gate resistor	$R_G$	$T_{vj}=25^\circ\text{C}$		5		$\Omega$	
Input capacitance	$C_{ies}$	$T_{vj}=25^\circ\text{C} f=1\text{MHz}, V_{CE}=25\text{V}, V_{GE}=0\text{V}$		23.8		nF	
Output capacitance	$C_{oes}$	$T_{vj}=25^\circ\text{C} f=1\text{MHz}, V_{CE}=25\text{V}, V_{GE}=0\text{V}$		1.1		nF	
Reverse transfer capacitance	$C_{res}$	$T_{vj}=25^\circ\text{C}, f=1\text{MHz}, V_{GE}=0\text{V}, V_{CE}=25\text{V}$		0.22		nF	
Collector-emitter cut-off current	$I_{CES}$	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}$	$T_{vj}=25^\circ\text{C}$		1	mA	
			$T_{vj}=150^\circ\text{C}$		4	mA	
Gate-emitter leakage current	$I_{GES}$	$V_{CE}=0\text{V}, V_{GE}=20\text{V}, T_{vj}=25^\circ\text{C}$			400	nA	
Turn-on delay time	$t_{d\ on}$	$I_c=200\text{A}, V_{CE}=600\text{V}, V_{GE}=-8\text{V}/+15\text{V}, R_{Gon}=0.22\Omega, R_{Goff}=6.1\Omega, \text{Inductive Load}$	$T_{vj}=25^\circ\text{C}$	0.26		$\mu\text{s}$	
			$T_{vj}=125^\circ\text{C}$	0.27		$\mu\text{s}$	
			$T_{vj}=150^\circ\text{C}$	0.27		$\mu\text{s}$	
Rise time	$t_r$		$T_{vj}=25^\circ\text{C}$	0.04		$\mu\text{s}$	
			$T_{vj}=125^\circ\text{C}$	0.05		$\mu\text{s}$	
			$T_{vj}=150^\circ\text{C}$	0.06		$\mu\text{s}$	
Turn-off delay time	$t_{d\ off}$		$T_{vj}=25^\circ\text{C}$	0.95		$\mu\text{s}$	
			$T_{vj}=125^\circ\text{C}$	1.08		$\mu\text{s}$	
			$T_{vj}=150^\circ\text{C}$	1.12		$\mu\text{s}$	
Fall time	$t_f$		$T_{vj}=25^\circ\text{C}$	0.06		$\mu\text{s}$	
			$T_{vj}=125^\circ\text{C}$	0.18		$\mu\text{s}$	
			$T_{vj}=150^\circ\text{C}$	0.22		$\mu\text{s}$	
Turn-on energy loss per pulse	$E_{on}$		$T_{vj}=25^\circ\text{C}$	11.7		mJ	
			$T_{vj}=125^\circ\text{C}$	16.9		mJ	
			$T_{vj}=150^\circ\text{C}$	18.6		mJ	
Turn-off energy loss per pulse	$E_{off}$		$T_{vj}=25^\circ\text{C}$	24.8		mJ	
			$T_{vj}=125^\circ\text{C}$	27.8		mJ	
			$T_{vj}=150^\circ\text{C}$	29.2		mJ	
Thermal resistance, junction to case	$R_{thJC}$	per IGBT			0.157	K/W	

### MAXIMUM RATED VALUES(FRD)

Parameter	Symbol	Conditions	Values	Units	
Repetitive peak reverse voltage	$V_{RRM}$	$T_{vj}=25^\circ\text{C}$	1200	V	
Continuous forward current	$I_{FN}$	$T_C=100^\circ\text{C}, T_{vj\ max}=175^\circ\text{C}$	200	A	
Maximum repetitive forward current	$I_{FRM}$	$t_P=1\text{ms}$	400	A	
$\text{P}_t$ -value	$\text{P}_t$	$V_R=0\text{V}, t_P=10\text{ms}$	$T_{vj}=125^\circ\text{C}$	9000	$\text{A}^2\text{s}$
			$T_{vj}=150^\circ\text{C}$	7200	

### CHARACTERISTICS VALUES(FRD)

Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Forward voltage	$V_F$	$I_F=200A, V_{GE}=0V$	$T_{vj}=25^\circ C$		1.8	V
			$T_{vj}=125^\circ C$		1.87	V
			$T_{vj}=150^\circ C$		1.9	V
Peak reverse recovery current	$I_{RM}$	$I_F=200A, V_R=600V, V_{GE}=-8V, di_F/dt=3600A/\mu s (T_{vj}=150^\circ C)$	$T_{vj}=25^\circ C$		172	A
			$T_{vj}=125^\circ C$		183	A
			$T_{vj}=150^\circ C$		200	A
Recovered charge	$Q_r$	$I_F=200A, V_R=600V, V_{GE}=-8V, di_F/dt=3600A/\mu s (T_{vj}=150^\circ C)$	$T_{vj}=25^\circ C$		11.3	$\mu C$
			$T_{vj}=125^\circ C$		21.1	$\mu C$
			$T_{vj}=150^\circ C$		28.3	$\mu C$
Reverse recovery energy	$E_{rec}$		$T_{vj}=25^\circ C$		5	mJ
			$T_{vj}=125^\circ C$		8.5	mJ
			$T_{vj}=150^\circ C$		11.6	mJ
Thermal resistance, junction to case	$R_{thJC}$	per FRD			0.22	K/W

### NTC-THERMISTOR

Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Rated resistance	$R_{25}$	$T_c=25^\circ C$		5.0		kΩ
Deviation of R100	$\Delta R/R$	$T_c=100^\circ C, R_{100}=493\Omega$	-3		3	%
Power dissipation	$P_{25}$	$T_c=25^\circ C$			60	mW
B-value	$B_{25/50}$	$R_2=R_{25} \exp[B_{25/50}(1/T_2-1/(298.15K))]$		3375		K
B-value	$B_{25/80}$	$R_2=R_{25} \exp[B_{25/80}(1/T_2-1/(298.15K))]$		3411		K
B-value	$B_{25/100}$	$R_2=R_{25} \exp[B_{25/100}(1/T_2-1/(298.15K))]$		3433		K

### CHARACTERISTICS VALUES(MODULE)

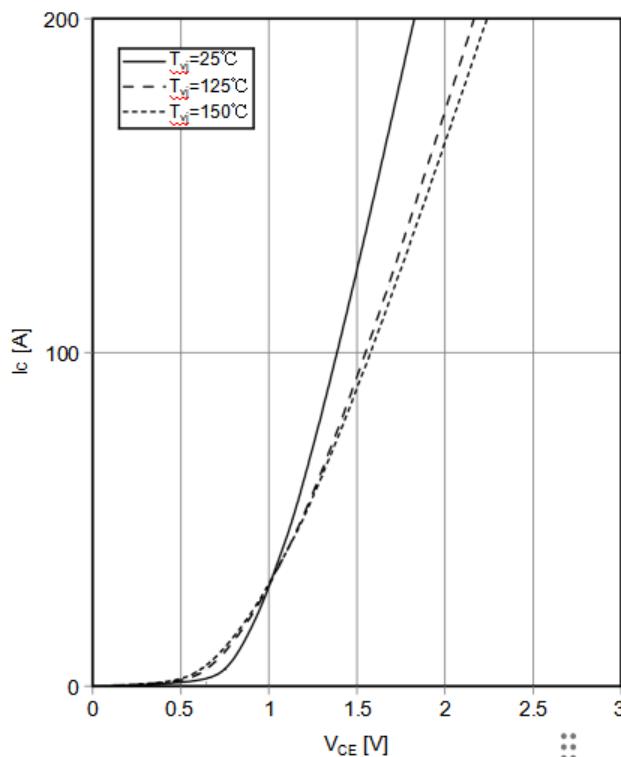
Parameter	Symbol	Conditions	Values			Units
			Min.	Typ.	Max.	
Maximum junction temperature	$T_{vj \ max}$	-			175	°C
Temperature under switching conditions	$T_{vj \ op}$	-	-40		150	°C
Storage temperature	$T_{stg}$	-	-40		125	°C
Stray inductance module	$L_{sCE}$	-		21		nH
Module lead resistance, terminals-chip	$R_{CC'EE'}$	$T_{vj}=25^\circ C$ , per switch		1.2		mΩ
Isolation test voltage	$V_{ISOL}$	RMS, f=50Hz, t=1min		2.5		kV
Creepage distance	$ds$	Terminal to heatsink		14.5		mm
		Terminal to terminal		13		mm

Clearance distance	da	Terminal to heatsink	12.5		mm
		Terminal to terminal	10		mm
Comperative tracking index	CTI	-	>200		-
Mounting torque for module mounting	M1	Screw M5	3	-	6 N·m
Terminal connection torque	M2	Screw M6	3	-	6 N·m
Internal isolation	-	Basic insulation (class1, IEC 61140)	$\text{Al}_2\text{O}_3$		-
Material of module baseplate	-	-	Cu+Ni		-
Dimensions	LxWxH	-	152.1x62x20.8 mm		
Weight	G	-	338 g		

## CHARACTERISTICS DIAGRAMS

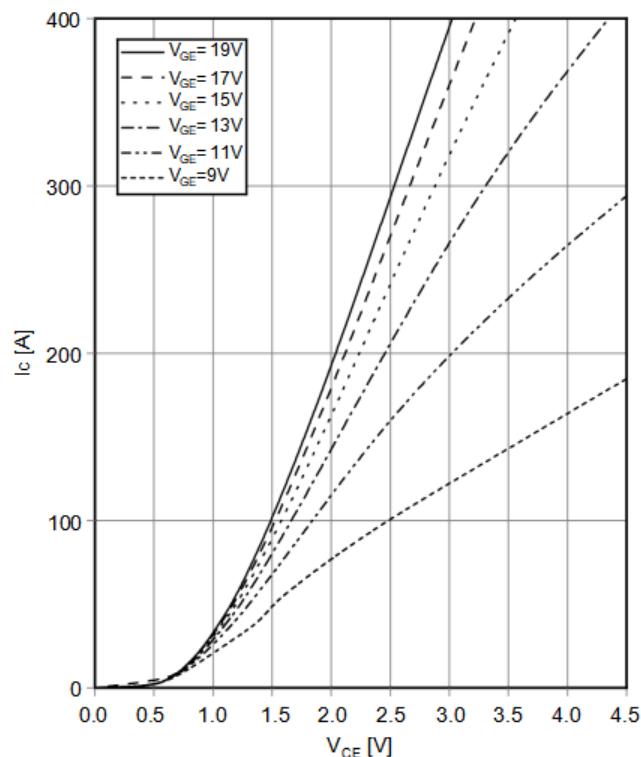
**Output characteristic IGBT, Inverter(typical)**

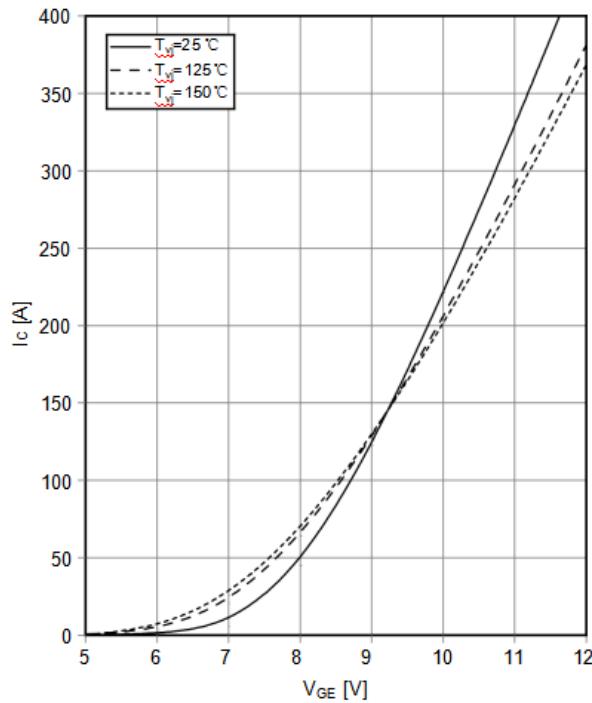
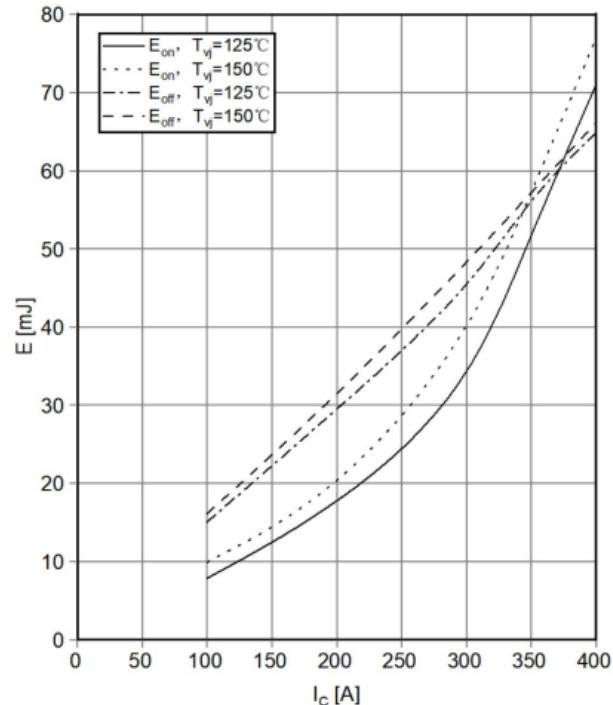
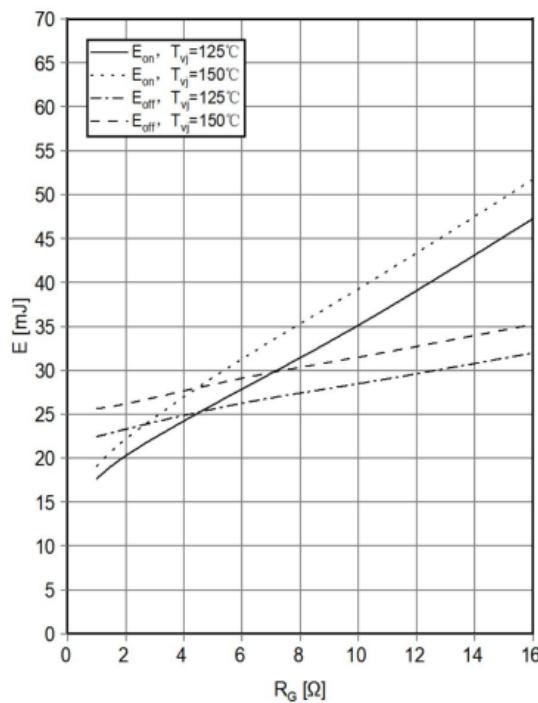
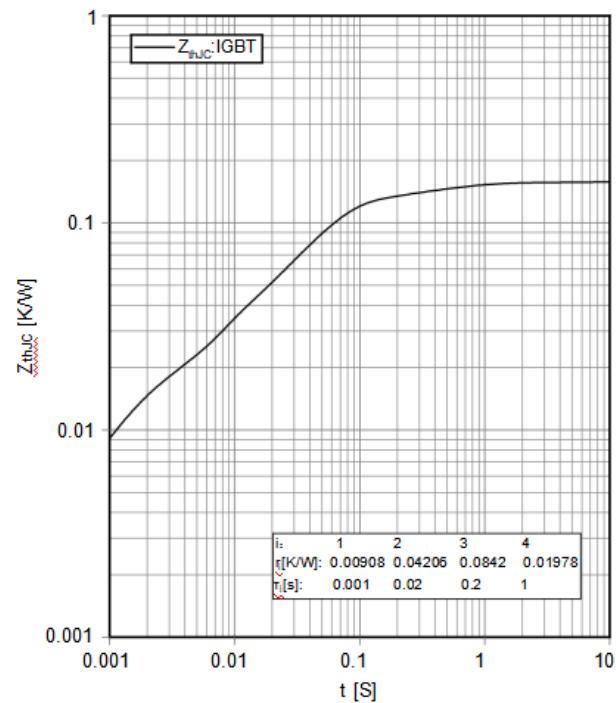
$I_C = f(V_{CE})$ ,  $V_{GE} = 15V$



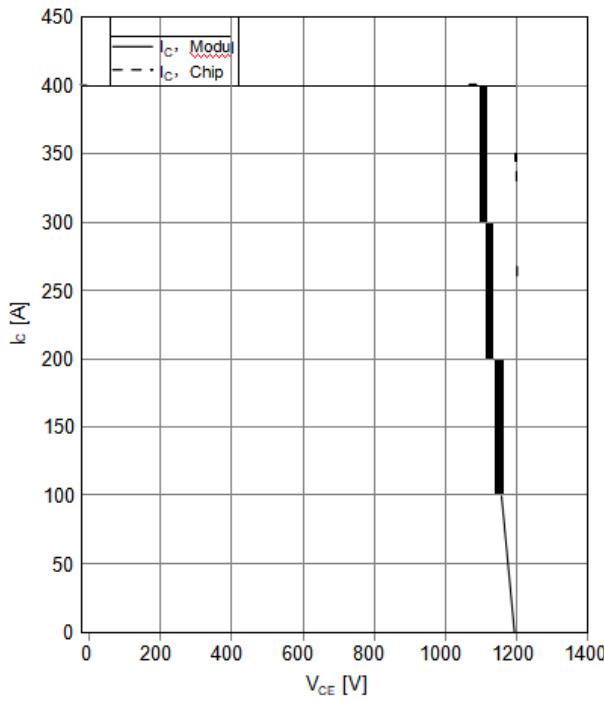
**Output characteristic IGBT, Inverter(typical)**

$I_C = f(V_{CE})$ ,  $T_j = 150^\circ\text{C}$

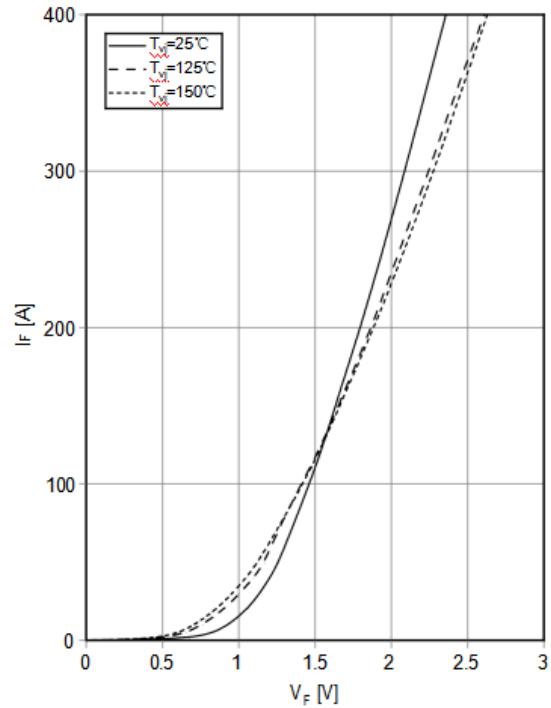


**Transfer characteristic IGBT, Inverter(typical)**
 $I_C = f(V_{GE})$ ,  $V_{CE} = 20V$ 

**Switching losses IGBT, Inverter(typical)**
 $E_{on} = f(I_C)$ ,  $E_{off} = f(I_C)$ ,  $V_{GE} = -8V/+15V$ ,  $R_{Gon} = 0.22\Omega$ ,  $R_{Goff} = 6.1\Omega$ ,  $V_{CE} = 600V$ 

**Switching losses IGBT, Inverter(typical)**
 $E_{on} = f(R_G)$ ,  $E_{off} = f(R_G)$ ,  $V_{GE} = -8V/+15V$ ,  $I_C = 200A$ ,  $V_{CE} = 600V$ 

**Transient thermal impedance IGBT, Inverter**
 $Z_{thJC} = f(t)$ 


**Everse bias safe operating area IGBT, Inverter(RBSOA)**  
 $I_c=f(V_{CE})$ ,  $V_{GE}=15V$ ,  $R_{Gon}=0.22\Omega$ ,  $T_{vj}=150^\circ C$

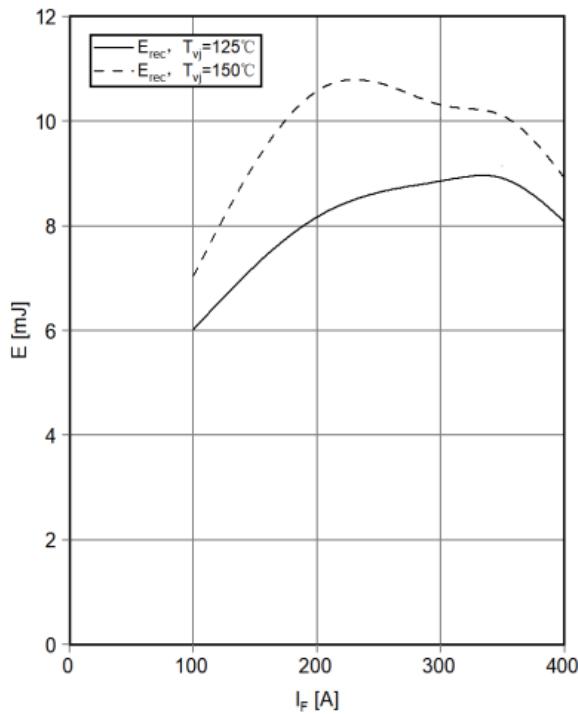


**Forward characteristic of FRD, Inverter(typical)**  
 $I_f=f(V_F)$



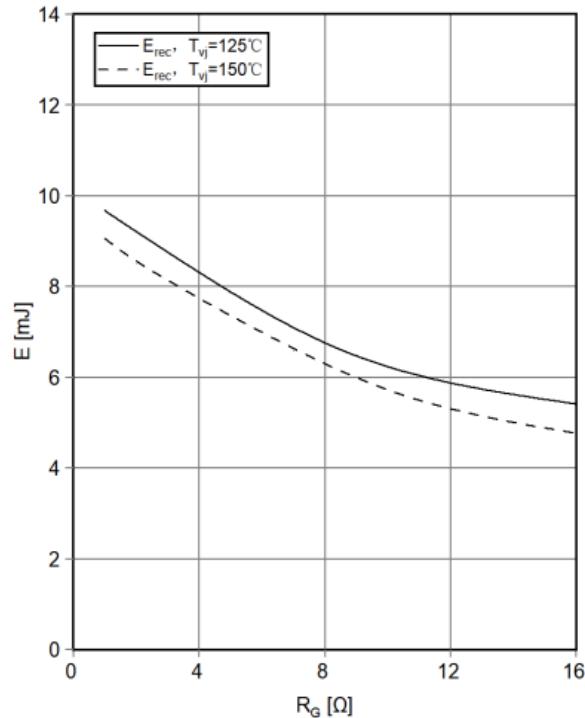
**Switching losses FRD, Inverter(typical)**

$E_{rec}=f(I_F)$ ,  $R_{Gon}=0.22\Omega$ ,  $V_{CE}=600V$



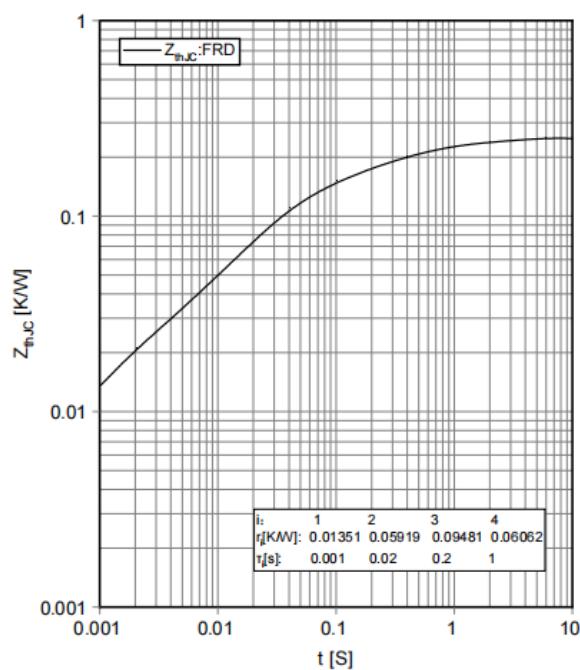
**Switching losses FRD, Inverter(typical)**

$E_{rec}=f(R_G)$ ,  $I_F=200A$ ,  $V_{CE}=600V$



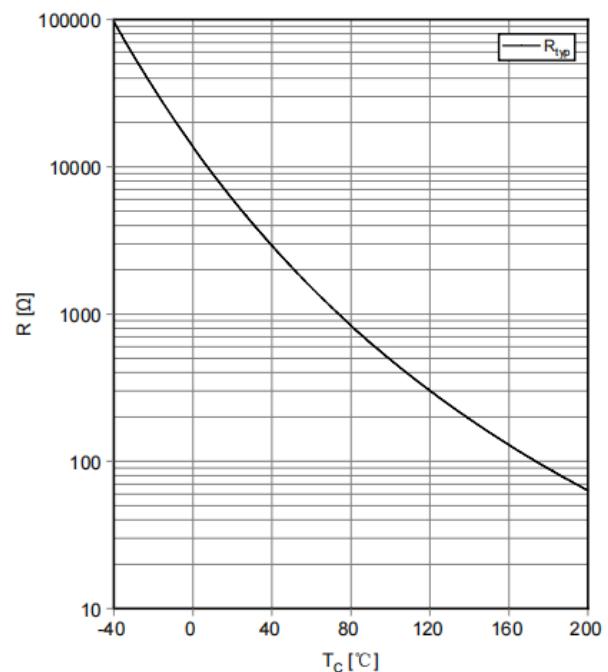
Transient thermal impedance FRD, Inverter

$Z_{th,JC} = f(t)$

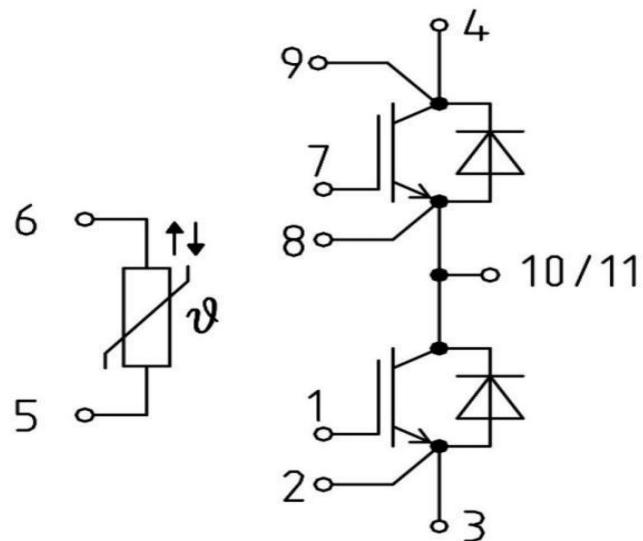


NTC-Thermistor-temperature characteristic(typical)

$R = f(T)$

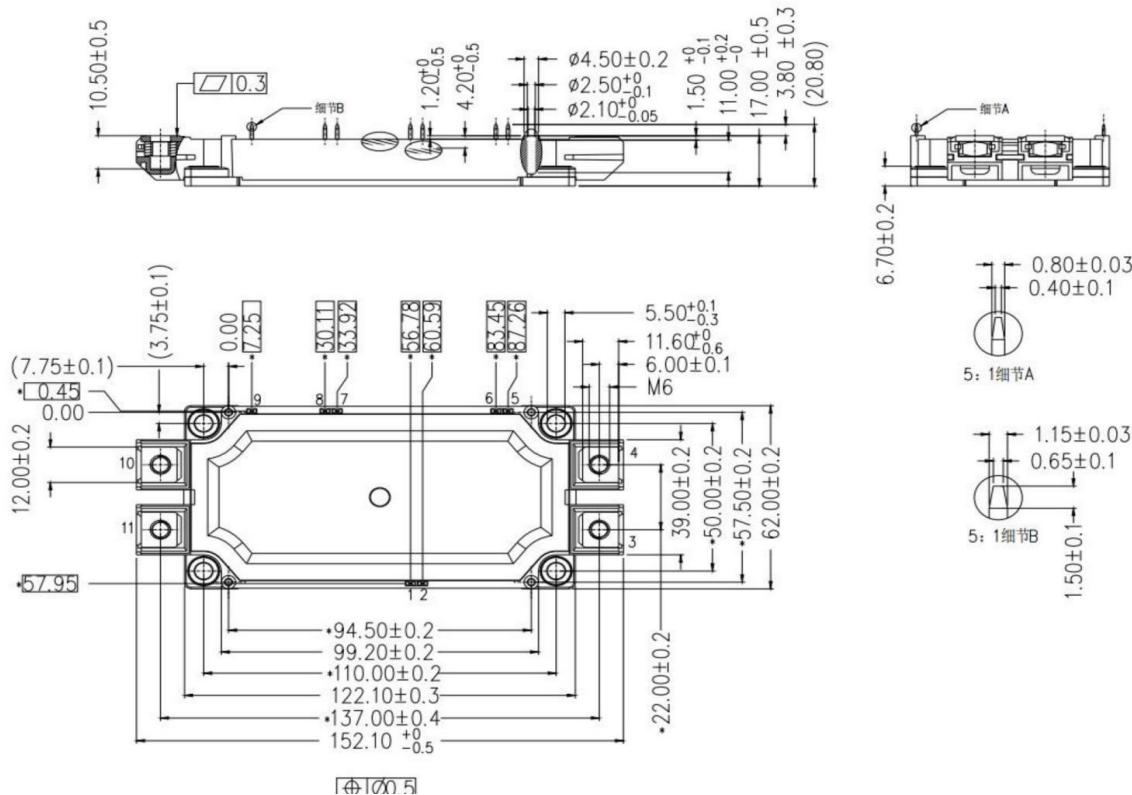


## CIRCUIT DIAGRAM



## PACKAGE OUTLINES

(NEXT PAGE)



## NOTICE

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Date of change	Rev #	revise content
2023/09/26	A/0	Initial releases
2024/05/06	A/1	Update test data